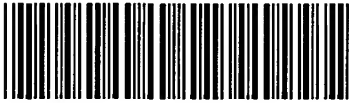


Search Notes

Application/Control No.

10/664,168

Examiner

Anh T.N. Vo

Applicant(s)/Patent under
Reexamination

HAAN ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
<i>updated search 03/06 MV</i>			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR